

TEST REPORT No. I18Z60981-EMC01

for

TCL Communication Ltd.

LTE / UMTS / GSM mobile phone

Model Name: 5033X

FCC ID: 2ACCJH095

with

Hardware Version: 05

Software Version: v7LT8

Issued Date: 2018-07-13



Note:

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Test Laboratory:

CTTL, Telecommunication Technology Labs, CAICT

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REPORT HISTORY

Report Number	Revision	Description	Issue Date
I18Z60981-EMC01	Rev.0	1 st edition	2018-06-26
I18Z60981-EMC01	Rev.1	Add KDB 484596 in the	2018-07-13
		statements on page 8	



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1. Test Laboratory

1.1. Testing Location

CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,

P. R. China 100191

1.2. <u>Testing Environment</u>

Normal Temperature: $15-35^{\circ}$ C Relative Humidity: 20-75%

1.3. Project data

Testing Start Date: 2018-04-12 Testing End Date: 2018-04-20

1.4. Signature

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(Prepared this test report)

长 新

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(Reviewed this test report)

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Deputy Director of the laboratory

(Approved this test report)



2. Client Information

2.1. Certification Contact Information

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2.2. Applicant Information

Company Name: TCL Communication Ltd.

7/F, Block F4, TCL Communication Technology Building, TCL

Address / Post: International E City, Zhong Shan Yuan Road, Nanshan District,

Shenzhen, Guangdong, P.R. China 518052

Contact Person: Zhizhou Gong

Contact Email: zhizhou.gong@tcl.com Telephone: 0086-755-36611722

2.3. Manufacturer Information

Company Name: TCL Communication Ltd.

7/F, Block F4, TCL Communication Technology Building, TCL

Address / Post: International E City, Zhong Shan Yuan Road, Nanshan District,

Shenzhen, Guangdong, P.R. China 518052

Contact Person: Zhizhou Gong

Contact Email: zhizhou.gong@tcl.com Telephone: 0086-755-36611722



3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description LTE / UMTS / GSM mobile phone

Model Name 5033X

FCC ID 2ACCJH095

Extreme vol. Limits 3.5VDC to 4.4VDC (nominal: 3.8VDC)

Note: Components list, please refer to documents of the manufacturer; it is also included in the original test record of CTTL, Telecommunication Technology Labs, CAICT.

3.2. Internal Identification of EUT used during the test

EUT ID*	SN or IMEI	HW Version	SW Version
EUT1	356270090200022	05	v7LT8

^{*}EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE used during the test

AE ID*	Description	SN	Remarks
AE1	Battery	/	1860562BA001
AE2	Charger	/	16TCT-CH-1675
AE3	Charger	/	1860562CH004
AE4	Charger	/	1860562CH002
AE5	USB Cable	/	16TCT-DC-0029
AE6	USB Cable	/	17TCT-DC-0492
AE7	Charger	/	/
AE8	Charger	/	/
AE9	Charger	/	/
AE10	Charger	/	/
AE11	Charger	/	/
AE12	Charger	/	/

AE1

Model CAB1930000C7

Manufacturer Ningbo Veken Battery Co.,LTD

Capacitance 2000mAh Nominal voltage 3.85V

AE2

Model CBA0066AGAC5

Manufacturer PUAN

Length of cable

AE3

Model CBA0066AGAC7 Manufacturer CHENYANG

Length of cable /



AE4

Model CBA3068AGAC5

Manufacturer PUAN

Length of cable /

AE5

Model CDA3122005C1

Manufacturer HUIZHOU JUWEI ELECTRONICS CO.,LTD

Length of cable 100cm

AE6

Model CDA3122005C2

Manufacturer ShengHua Industrial Co., Ltd

Length of cable 100cm

AE7

Model CBA0066AAAC5

Manufacturer HUIZHOU PUAN ELECTRONICS CO.,LTD

Length of cable /

AE8

Model CBA0066AAAC7

Manufacturer JIANGSU CHENYANG ELECTRON CO.,LTD

Length of cable /

AE9

Model CBA0066ABAC5

Manufacturer PUAN

Length of cable /

AE10

Model CBA0066ABAC7
Manufacturer CHENYANG

Length of cable /

AE11

Model CBA3068AAAC5

Manufacturer HUIZHOU PUAN ELECTRONICS CO.,LTD

Length of cable /

AE12

Model CBA3068ABAC5

Manufacturer PUAN

Length of cable /

*AE ID: is used to identify the test sample in the lab internally.

Note: The USB cables are shielded.



3.4. EUT set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.1	EUT1+ AE1+ AE2+ AE5/AE6	Charger
Set.2	EUT1+ AE1+ AE3+ AE5/AE6	Charger
Set.3	EUT1+ AE1+ AE4+ AE5/AE6	Charger
Set.4	EUT1+ AE1+ AE5/AE6	USB mode

Note: LTE / UMTS / GSM mobile phone, 5033X manufactured by TCL Communication Ltd is a variant model based on 5033A for conformance test. According to the KDB 484596, no test needs to been performed, all results are cited from the initial model. The report number for initial model is I18Z60562-EMC01.



4. Reference Documents

4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part 15, Subpart B	Radio frequency devices - Unintentional Radiators	2016
ANSI C63.4	American National Standard for	2014
	Methods of Measurement of Radio-	
	Noise Emissions from Low-Voltage	
	Electrical and Electronic Equipment	
	in the Range of 9 kHz to 40 GHz	

Note: The test methods have no deviation with standards.



5. LABORATORY ENVIRONMENT

Semi-anechoic chamber SAC-1 (23 meters × 17meters × 10meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 15 %, Max. = 75 %
Shielding effectiveness	0.014MHz - 1MHz, >60dB;
Sillerding effectiveness	1MHz - 1000MHz, >90dB.
Electrical insulation	> 2 M
Ground system resistance	< 4
Normalised site attenuation (NSA)	< ± 4 dB, 3m/10m distance,
The state of the s	from 30 to 1000 MHz
Site voltage standing-wave ratio (SVSWR)	Between 0 and 6 dB, from 1GHz to 18GHz
Uniformity of field strength	Between 0 and 6 dB, from 80 to 3000 MHz

Shielded room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	0.014MHz-1MHz, >60dB;
	1MHz-1000MHz, >90dB.
Electrical insulation	> 2 MΩ
Ground system resistance	< 4 Ω



6. SUMMARY OF TEST RESULTS

Abbreviations used in this clause:		
	Р	Pass
Verdict Column	NA	Not applicable
	F	Fail

Items	Test Name	Clause in FCC rules	Section in this report	Verdict	Test Location
1	Radiated Emission	15.109(a)	B.1	Р	CTTL(huayuan North Road)
2	Conducted Emission	15.107(a)	B.2	Р	CTTL(huayuan North Road)



7. Test Equipments Utilized

NO.	Description	TYPE	SERIES NUMBER	MANUFACTURE	CAL DUE DATE	CALIBRA TION INTERVA L
1	Test Receiver	ESU26	100235	R&S	2019-02-28	1 year
2	Test Receiver	ESCI 7	100344	R&S	2019-02-28	1 year
3	Universal Radio Communication Tester	CMU200	109914	R&S	2019-04-01	1 year
4	Universal Radio Communication Tester	CMW500	116588	R&S	2018-12-26	1 year
5	LISN	ENV216	101200	R&S	2018-08-03	1 year
6	EMI Antenna	VULB 9163	9163-301	Schwarzbeck	2019-01-03	3 years
7	EMI Antenna	3115	00167250	ETS-Lindgren	2018-05-21	3 years
8	PC	OPTIPLEX 380	2X1YV2X	DELL	N/A	N/A
9	Printer	P1606dn	VNC3L52122	HP	N/A	N/A

Test Item	Test Software and Version	Software Vendor
Radiated Continuous Emission	EMC32 V9.01	R&S
Conducted Emission	EMC32 V8.52.0	R&S



ANNEX A: MEASUREMENT RESULTS

A.1 Radiated Emission

Reference

FCC: CFR Part 15.109(a).

A.1.1 Method of measurement

The field strength of radiated emissions from the unintentional radiator (USB mode of MS and charging mode of MS) at distances of 10 meters(for 30MHz-1GHz) and 3 meters (for above 1GHz) is tested. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 8.3.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a

distance of 3/10 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

A.1.2 EUT Operating Mode

The MS is operating in the USB mode and charging mode. During the test MS is connected to a PC via a USB cable in the case of USB mode and is connected to a charger in the case of charging mode. The model of the PC is DELL OPTIPLEX 380, and the serial number of the PC is 2X1YV2X. The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

A.1.3 Measurement Limit

Frequency range	Field strength limit (μV/m)						
(MHz)	Quasi-peak	Average	Peak				
30-88	100						
88-216	150						
216-960	200						
960-1000	500						
>1000		500	5000				

Note: the above limit is for 3 meters test distance. 10 meters' limit is got by converting.

A.1.4 Test Condition

Frequency range (MHz)	RBW/VBW	Sweep Time (s)	Detector
30-1000	120kHz (IF Bandwidth)	5	Peak/Quasi-peak
Above 1000	1MHz/1MHz	15	Peak, Average



A.1.5 Measurement Results

A "reference path loss" is established and the A_{Rpl} is the attenuation of "reference path loss". It includes the antenna factor of receive antenna and the path loss.

The measurement results are obtained as described below:

Result = $P_{Mea} + A_{Rpl} = P_{Mea} + G_A + G_{PL}$

Where

G_A: Antenna factor of receive antenna

G_{PL}: Path Loss

P_{Mea}: Measurement result on receiver.

Measurement uncertainty (worst case): U = 4.3 dB, k=2.

Measurement results for Set.1:

Charging Mode/Average detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency	Result	loss	Factor	Reading	Pol.	
(MHz)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17858.050	38.7	-18.5	45.6	11.600	Н	
17387.150	38.6	-19.5	41.5	16.600	Н	
17787.500	38.4	-18.5	45.6	11.300	V	
17371.850	38.4	-19.5	41.5	16.400	Н	
17908.200	17908.200 38.4		45.6	11.300	Н	
17588.600	38.2	-18.9	45.6	11.500	Н	

Charging Mode/Peak detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency (MHz)	Result	loss	Factor	Reading	Pol.	
(IVITIZ)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17978.750	50.2	-17.7	45.6	22.300	Н	
17902.250	49.3	-18.5	45.6	22.200	Н	
17818.100	48.8	-18.5	45.6	21.700	V	
17869.950	48.6	-18.5	45.6	21.500	Н	
17618.350	17618.350 48.6		45.6	21.900	Н	
17716.950	48.6	-18.9	45.6	21.900	Н	



Measurement results for Set.2: Charging Mode/Average detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency	Result	loss	Factor	Reading	Pol.	
(MHz)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17416.050	6.050 38.7		41.5	16.400	Н	
17903.100	3.100 38.6		45.6	11.500	Н	
17371.000	38.4	-19.5	41.5	16.400	V	
17459.400	38.4	-19.2	41.5	16.100	Н	
17975.350	17975.350 38.4		45.6	10.500	Н	
17869.100	38.4	-18.5	45.6	11.300	Н	

Charging Mode/Peak detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency (MHz)	Result	loss	Factor	Reading	Pol.	
(IVITZ)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17757.750	57.750 49.1		45.6	22.000	Н	
17422.000	49.0	-19.2	41.5	26.700	Н	
17881.000	49.0	-18.5	45.6	21.900	V	
17462.800	52.800 49.0		41.5	26.700	Н	
17914.150	17914.150 48.9		45.6	21.800	Н	
17427.950	48.8	-19.2	41.5	26.500	Н	



Measurement results for Set.3: Charging Mode/Average detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna		
Frequency	Result	loss	Factor	Reading	Pol.		
(MHz)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)		
17763.700	38.5		17763.700 38.5		45.6	11.400	Н
17897.150	38.5	-18.5	45.6	11.400	Н		
17908.200	38.4	-18.5	45.6	11.300	V		
17906.500	38.3	-18.5	45.6	11.200	Н		
17282.600	17282.600 38.3		41.5	16.300	Н		
17893.750	38.2	-18.5	45.6	11.100	Н		

Charging Mode/ Peak detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency (MHz)	Result	loss	Factor	Reading	Pol.	
(IVITZ)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17858.050	858.050 48.9		45.6	21.800	Н	
17227.350	48.8	-19.5	41.5	26.800	Н	
17869.950	48.7	-18.5	45.6	21.600	V	
17381.200	7381.200 48.7		41.5	26.700	Н	
17832.550 48.7		-18.5	45.6	21.600	Н	
17897.150	48.6	-18.5	45.6	21.500	Н	



Measurement results for Set.4: USB Mode/Average detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency	Result	loss	Factor	Reading	Pol.	
(MHz)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17888.367	17888.367 37.4		45.6	10.300	Н	
17365.900	37.4	-19.5	41.5	15.400	Н	
17789.200	37.4	-18.5	45.6	10.300	V	
17891.767	37.2	-18.5	45.6	10.100	Н	
17773.333 37.2		-18.5 45.6		10.100	Н	
17875.333	37.2	-18.5	45.6	10.100	Н	

USB Mode/ Peak detector

Fraguency	Measurement	Cable	Antenna	Receiver	Antenna	
Frequency	Result	loss	Factor	Reading	Pol.	
(MHz)	(dBμV/m)	(dB)	(dB/m)	(dBμV)	(H/V)	
17411.800	49.8	-19.2	41.5	27.500	Н	
17535.333	5.333 49.1		45.6	22.700	Н	
17769.933	48.6	-18.5	45.6	21.500	V	
17912.167	48.6	-18.5	45.6	21.500	Н	
17941.067	17941.067 48.5		45.6	20.600	Н	
17389.700	17389.700 48.5		41.5	26.200	Н	

Note: The measurement results of Set.1, Set.2, Set.3 and Set.4 showed here are worst cases of the combinations of different USB cables.



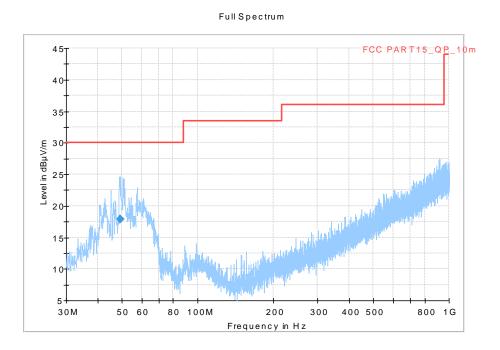


Fig A.1 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Limit	Margin	Meas. Time	Bandwidth	Height	Pol	Azimuth	
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	(ms)	(kHz)	(cm)		(deg)	
49.418000	17.85	30.00	12.15	1000.0	120.000	176.0	٧	30.0	

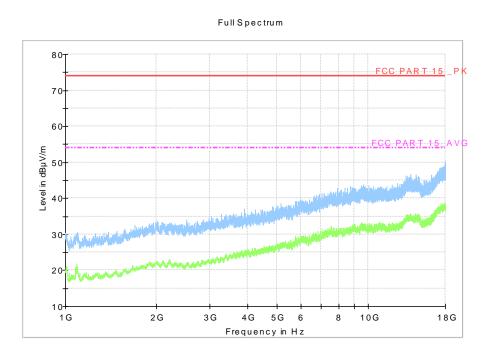


Fig A.2 Radiated Emission from 1GHz to 18GHz



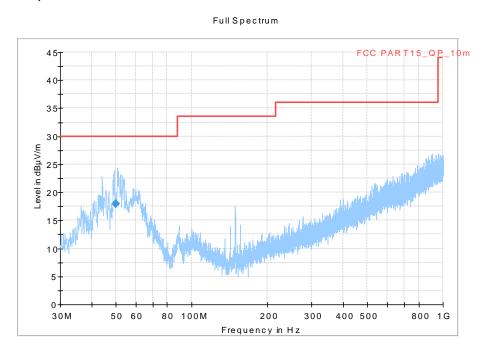


Fig A.3 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Limit	Margin	Meas. Time	Bandwidth	Height	Pol	Azimuth
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	(ms)	(kHz)	(cm)		(deg)
50.061000	18.01	30.00	11.99	1000.0	120.000	111.0	٧	30.0



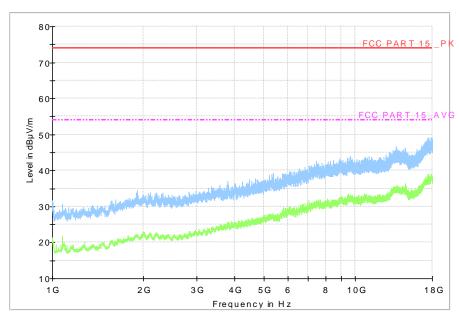


Fig A.4 Radiated Emission from 1GHz to 18GHz



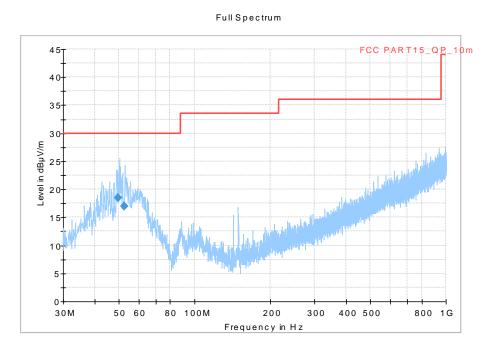


Fig A.5 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Limit	Margin	Meas. Time	Bandwidth	Height	Pol	Azimuth
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	(ms)	(kHz)	(cm)		(deg)
49.576000	18.50	30.00	11.50	1000.0	120.000	125.0	V	30.0
52.532000	16.96	30.00	13.04	1000.0	120.000	100.0	V	195.0

FullSpectrum

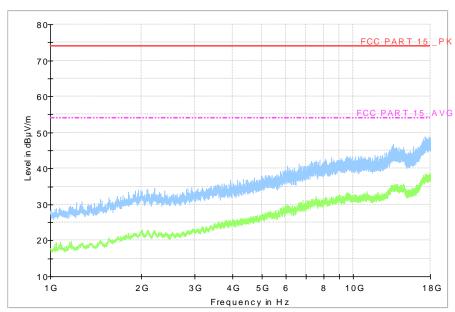


Fig A.6 Radiated Emission from 1GHz to 18GHz



USB Mode, Set.4

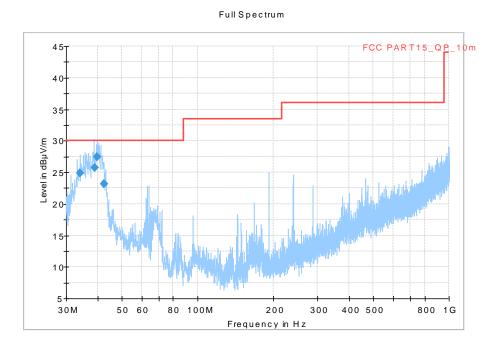


Fig A.7 Radiated Emission from 30MHz to 1GHz

Frequency	QuasiPeak	Limit	Margin	Meas. Time	Bandwidth	Height	Pol	Azimuth
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	(ms)	(kHz)	(cm)		(deg)
34.074000	24.91	30.00	5.09	1000.0	120.000	184.0	V	202.0
39.090000	25.79	30.00	4.21	1000.0	120.000	325.0	٧	93.0
39.857000	27.45	30.00	2.55	1000.0	120.000	125.0	٧	97.0
42.495000	23.22	30.00	6.78	1000.0	120.000	278.0	٧	174.0



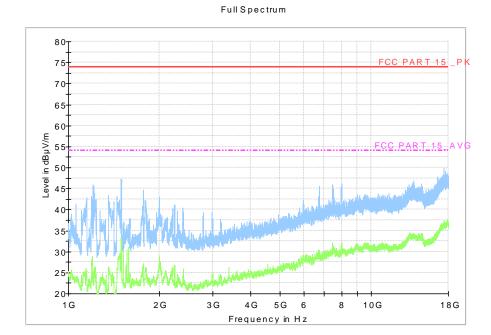


Fig A.8 Radiated Emission from 1GHz to 18GHz



A.2 Conducted Emission

Reference

FCC: CFR Part 15.107(a).

A.2.1 Method of measurement

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz to 30 MHz shall not exceed the limits. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 7.3.

A.2.2 EUT Operating Mode

The MS is operating in the USB mode and charging mode. During the test MS is connected to a PC via a USB cable in the case of USB mode and is connected to a charger in the case of charging mode. The model of the PC is DELL OPTIPLEX 380, and the serial number of the PC is 2X1YV2X. The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

Note: I/O information: Printer – USB, Mouse – PS/2, Keyboard – USB.

A.2.3 Measurement Limit

Frequency of emission (MHz)	Conducted limit (dBµV)						
	Quasi-peak	Average					
0.15-0.5	66 to 56*	56 to 46*					
0.5-5	56	46					
5-30	60	50					
*Decreases with the logarithm of the frequency							

A.2.4 Test Condition in charging mode

Voltage (V)	Frequency (Hz)
120	60

RBW/IF bandwidth	Sweep Time(s)
9kHz	1



A.2.5 Measurement Results

Measurement uncertainty: *U*= 2.9 dB, *k*=2.

Charging Mode, Set.1

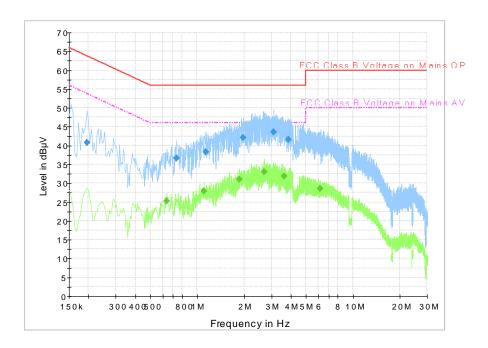


Fig A.9 Conducted Emission

Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.195000	40.7	2000.0	9.000	L1	19.8	23.1	63.8
0.735000	36.6	2000.0	9.000	L1	19.8	19.4	56.0
1.131000	38.4	2000.0	9.000	L1	19.6	17.6	56.0
1.968000	42.1	2000.0	9.000	L1	19.7	13.9	56.0
3.097500	43.5	2000.0	9.000	L1	19.7	12.5	56.0
3.844500	41.5	2000.0	9.000	L1	19.6	14.5	56.0

Final Result 2

Frequency	Average	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.636000	25.3	2000.0	9.000	L1	19.8	20.7	46.0
1.108500	27.8	2000.0	9.000	L1	19.6	18.2	46.0
1.869000	31.1	2000.0	9.000	L1	19.7	14.9	46.0
2.688000	33.0	2000.0	9.000	L1	19.7	13.0	46.0
3.628500	31.9	2000.0	9.000	L1	19.6	14.1	46.0
6.171000	28.5	2000.0	9.000	L1	19.7	21.5	50.0



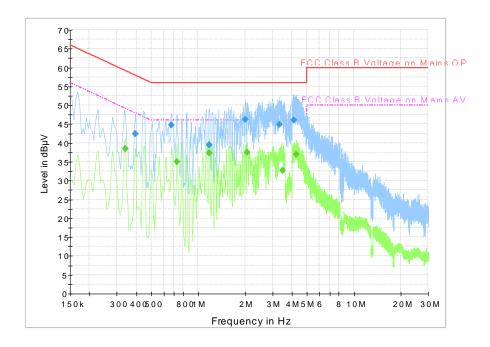


Fig A.10 Conducted Emission

Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.393000	42.5	2000.0	9.000	L1	19.9	15.5	58.0
0.672000	44.7	2000.0	9.000	L1	19.8	11.3	56.0
1.180500	39.5	2000.0	9.000	L1	19.6	16.5	56.0
2.004000	46.3	2000.0	9.000	L1	19.7	9.7	56.0
3.331500	45.0	2000.0	9.000	L1	19.7	11.0	56.0
4.110000	46.0	2000.0	9.000	L1	19.6	10.0	56.0

Final Result 2

Frequency	Average	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.339000	38.5	2000.0	9.000	L1	19.8	10.7	49.2
0.730500	35.0	2000.0	9.000	L1	19.8	11.0	46.0
1.176000	37.3	2000.0	9.000	L1	19.6	8.7	46.0
2.067000	37.5	2000.0	9.000	L1	19.7	8.5	46.0
3.484500	32.7	2000.0	9.000	L1	19.7	13.3	46.0
4.272000	37.0	2000.0	9.000	L1	19.6	9.0	46.0



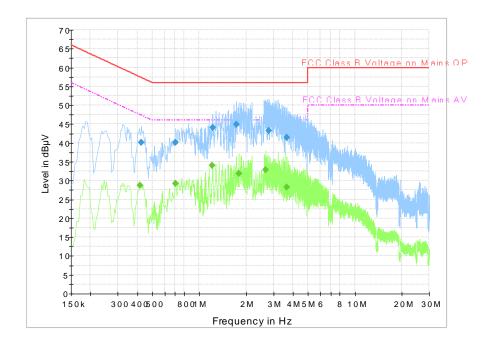


Fig A.11 Conducted Emission

Final Result 1

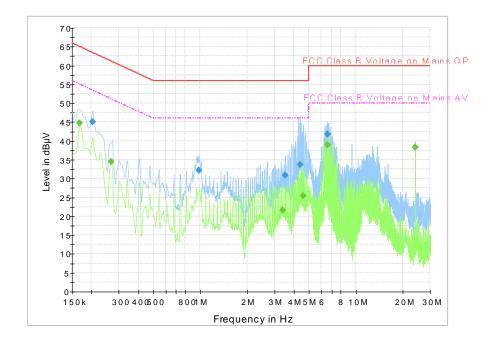
Frequency	QuasiPeak	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.424500	40.1	2000.0	9.000	L1	19.9	17.2	57.4
0.703500	40.1	2000.0	9.000	L1	19.8	15.9	56.0
1.216500	44.1	2000.0	9.000	L1	19.6	11.9	56.0
1.729500	44.9	2000.0	9.000	L1	19.7	11.1	56.0
2.796000	43.3	2000.0	9.000	L1	19.7	12.7	56.0
3.655500	41.5	2000.0	9.000	L1	19.6	14.5	56.0

Final Result 2

Frequency	Average	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.415500	28.7	2000.0	9.000	L1	19.9	18.9	47.5
0.703500	29.3	2000.0	9.000	L1	19.8	16.7	46.0
1.212000	34.1	2000.0	9.000	L1	19.6	11.9	46.0
1.797000	31.9	2000.0	9.000	L1	19.7	14.1	46.0
2.674500	32.9	2000.0	9.000	L1	19.7	13.1	46.0
3.655500	28.3	2000.0	9.000	L1	19.6	17.7	46.0



USB Mode, Set.4



Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.204000	45.1	2000.0	9.000	L1	19.8	18.3	63.4
0.978000	32.1	2000.0	9.000	N	19.7	23.9	56.0
3.520500	30.8	2000.0	9.000	N	19.7	25.2	56.0
4.398000	33.7	2000.0	9.000	N	19.7	22.3	56.0
6.598500	41.8	2000.0	9.000	N	19.8	18.2	60.0
24.009000	38.3	2000.0	9.000	N	20.2	21.7	60.0

Final Result 2

Frequency	Average	Meas.	Bandwidth	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	Time	(kHz)		(dB)	(dB)	(dBµV)
		(ms)					
0.168000	44.7	2000.0	9.000	L1	19.8	10.4	55.1
0.267000	34.4	2000.0	9.000	L1	19.8	16.8	51.2
3.381000	21.7	2000.0	9.000	N	19.7	24.3	46.0
4.600500	25.4	2000.0	9.000	N	19.7	20.6	46.0
6.598500	38.9	2000.0	9.000	N	19.8	11.1	50.0
24.009000	38.4	2000.0	9.000	N	20.2	11.6	50.0



ANNEX B: Accreditation Certificate

United States Department of Commerce National Institute of Standards and Technology



Certificate of Accreditation to ISO/IEC 17025:2005

NVLAP LAB CODE: 600118-0

Telecommunication Technology Labs, CAICT

Beijing China

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

Electromagnetic Compatibility & Telecommunications

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2016-09-29 through 2017-09-30

Effective Dates



For the National Voluntary Laboratory Accreditation Program

END OF REPORT